

Cascadable Silicon Bipolar MMIC Amplifiers

Technical Data

MSA-0335, -0336

Features

- **Cascadable 50 Ω Gain Block**
- **3 dB Bandwidth:**
DC to 2.7 GHz
- **12.0 dB Typical Gain at
1.0 GHz**
- **10.0 dBm Typical $P_{1\text{dB}}$ at
1.0 GHz**
- **Unconditionally Stable
($k > 1$)**
- **Cost Effective Ceramic
Microstrip Package**

Description

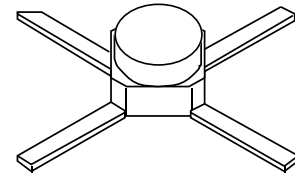
The MSA-0335 is a high performance silicon bipolar Monolithic Microwave Integrated Circuit (MMIC) housed in a cost effective, microstrip package. This MMIC is

designed for use as a general purpose 50 Ω gain block. Typical applications include narrow and broad band IF and RF amplifiers in industrial and military applications.

The MSA-series is fabricated using HP's 10 GHz f_T , 25 GHz f_{MAX} , silicon bipolar MMIC process which uses nitride self-alignment, ion implantation, and gold metallization to achieve excellent performance, uniformity and reliability. The use of an external bias resistor for temperature and current stability also allows bias flexibility.

Available in cut lead version (package 36) as MSA-0336.

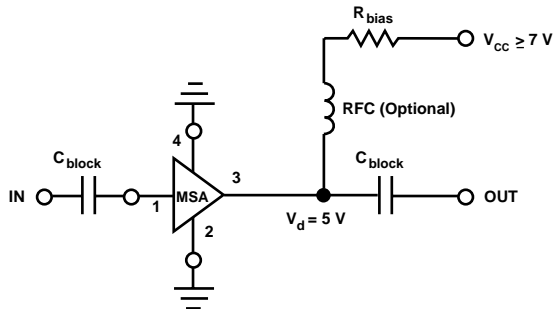
35 micro-X Package^[1]



Note:

1. Short leaved 36 package available upon request.

Typical Biasing Configuration



MSA-0335, -0336 Absolute Maximum Ratings

Parameter	Absolute Maximum ^[1]
Device Current	80 mA
Power Dissipation ^[2,3]	425 mW
RF Input Power	+13dBm
Junction Temperature	200°C
Storage Temperature ^[4]	-65 to 200°C

Thermal Resistance^[2,5]:

$$\theta_{jc} = 150^{\circ}\text{C}/\text{W}$$

Notes:

1. Permanent damage may occur if any of these limits are exceeded.
2. $T_{\text{CASE}} = 25^{\circ}\text{C}$.
3. Derate at 6.7 mW/°C for $T_{\text{C}} > 136^{\circ}\text{C}$.
4. Storage above +150°C may tarnish the leads of this package making it difficult to solder into a circuit.
5. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section “Thermal Resistance” for more information.

Electrical Specifications^[1], $T_{\text{A}} = 25^{\circ}\text{C}$

Symbol	Parameters and Test Conditions: $I_{\text{d}} = 35 \text{ mA}$, $Z_{\text{o}} = 50 \Omega$	Units	Min.	Typ.	Max.
GP	Power Gain ($ S_{21} ^2$) $f = 0.1 \text{ GHz}$	dB	11.5	12.5	13.5
ΔGP	Gain Flatness $f = 0.1 \text{ to } 1.6 \text{ GHz}$	dB		± 0.6	± 1.0
$f_{3 \text{ dB}}$	3 dB Bandwidth	GHz		2.7	
VSWR	Input VSWR $f = 0.1 \text{ to } 3.0 \text{ GHz}$			1.6:1	
	Output VSWR $f = 0.1 \text{ to } 3.0 \text{ GHz}$			1.7:1	
NF	50 Ω Noise Figure $f = 1.0 \text{ GHz}$	dB		10.0	
$P_{1 \text{ dB}}$	Output Power at 1 dB Gain Compression $f = 1.0 \text{ GHz}$	dBm		6.0	
IP_3	Third Order Intercept Point $f = 1.0 \text{ GHz}$	dBm		23.0	
t_{D}	Group Delay $f = 1.0 \text{ GHz}$	psec		125	
V_{d}	Device Voltage	V	4.5	5.0	5.5
dV/dT	Device Voltage Temperature Coefficient	mV/°C		-8.0	

Notes:

1. The recommended operating current range for this device is 20 to 50 mA. Typical performance as a function of current is on the following page.

MSA-0335, -0336 Part Number Ordering Information

Part Number	No. of Devices	Container
MSA-0335	10	Strip
MSA-0336-BLK	100	Antistatic Bag
MSA-0336-TR1	1000	7" Reel

For more information, see “Tape and Reel Packaging for Semiconductor Devices.”

MSA-0335, -0336 Typical Scattering Parameters ($Z_0 = 50 \Omega$, $T_A = 25^\circ\text{C}$, $I_d = 35 \text{ mA}$)

Freq. GHz	S_{11}		S_{21}			S_{12}			S_{22}	
	Mag	Ang	dB	Mag	Ang	dB	Mag	Ang	Mag	Ang
0.1	.05	177	12.6	4.25	175	-18.6	.118	1	.17	-8
0.2	.05	170	12.5	4.24	170	-18.3	.121	2	.17	-17
0.4	.04	161	12.5	4.20	160	-18.3	.122	3	.17	-33
0.6	.04	156	12.4	4.15	151	-18.3	.121	5	.18	-47
0.8	.03	149	12.2	4.09	142	-17.9	.128	8	.19	-61
1.0	.02	154	12.1	4.02	132	-17.6	.131	9	.20	-73
1.5	.03	-104	11.6	3.79	109	-16.8	.145	13	.20	-102
2.0	.08	-136	10.9	3.49	87	-15.7	.164	11	.21	-133
2.5	.14	-157	10.0	3.16	71	-14.9	.180	13	.23	-155
3.0	.21	-176	9.0	2.81	53	-14.6	.187	8	.24	-173
3.5	.27	170	7.9	2.49	36	-13.9	.202	4	.25	178
4.0	.31	157	6.9	2.20	20	-13.6	.209	-1	.24	177
5.0	.37	125	4.9	1.76	-10	-12.9	.226	-12	.20	165
6.0	.51	87	2.8	1.38	-38	-12.8	.230	-25	.22	130

A model for this device is available in the DEVICE MODELS section.

Typical Performance, $T_A = 25^\circ\text{C}$

(unless otherwise noted)

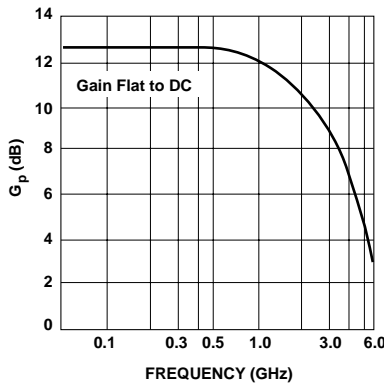


Figure 1. Typical Power Gain vs. Frequency, $T_A = 25^\circ\text{C}$, $I_d = 35 \text{ mA}$.

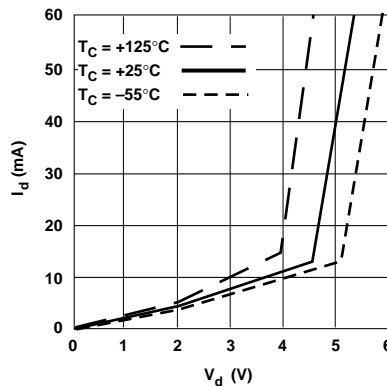


Figure 2. Device Current vs. Voltage.

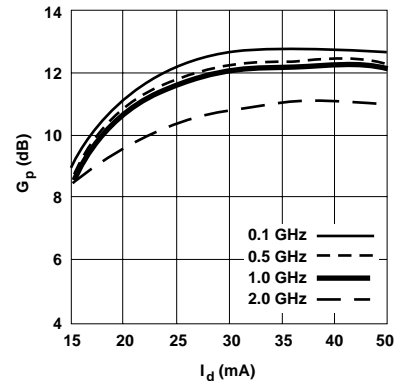


Figure 3. Power Gain vs. Current.

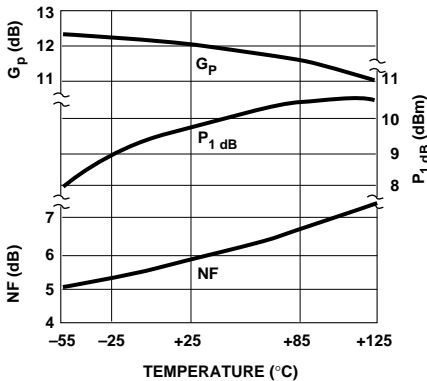


Figure 4. Output Power at 1 dB Gain Compression, NF and Power Gain vs. Mounting Surface Temperature, $f=1.0 \text{ GHz}$, $I_d = 35 \text{ mA}$.

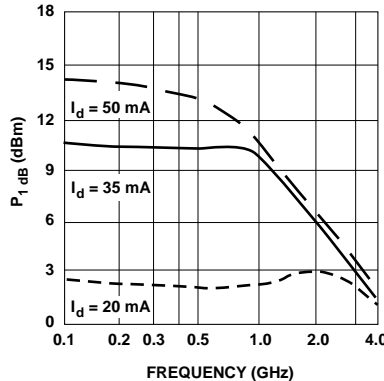


Figure 5. Output Power at 1 dB Gain Compression vs. Frequency.

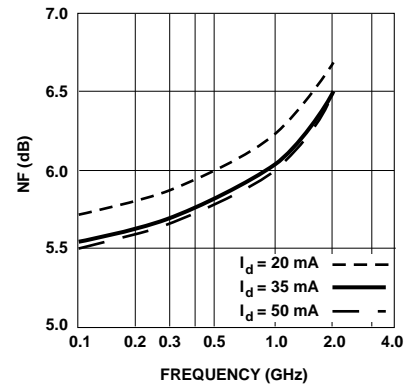


Figure 6. Noise Figure vs. Frequency.

35 micro-X Package Dimensions

